

### General Description

- Trench Power MV MOSFET technology
- Low  $R_{DS(ON)}$
- Low Gate Charge

### Product Summary

$V_{DS}$	40V
$I_D$ (at $V_{GS}=10V$ )	50A
$R_{DS(ON)}$ (at $V_{GS}=10V$ )	< 2.3mΩ
$R_{DS(ON)}$ (at $V_{GS}=4.5V$ )	< 3.5mΩ

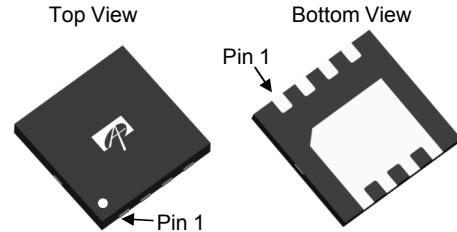
### Applications

- Synchronous Rectification for AC-DC/DC-DC converter
- Motor drive for 12V-24V systems
- O-ring switches

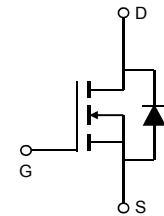
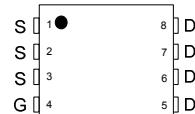
100% UIS Tested  
100%  $R_g$  Tested



DFN 3.3x3.3



Top View



### Orderable Part Number

AON7140

### Package Type

DFN 3.3x3.3

### Form

Tape &amp; Reel

### Minimum Order Quantity

3000

### Absolute Maximum Ratings $T_A=25^\circ C$ unless otherwise noted

Parameter	Symbol	Maximum	Units
Drain-Source Voltage	$V_{DS}$	40	V
Gate-Source Voltage	$V_{GS}$	$\pm 20$	V
Continuous Drain Current <sup>G</sup>	$I_D$	50	A
		50	
Pulsed Drain Current <sup>C</sup>	$I_{DM}$	200	
Continuous Drain Current <sup>A</sup>	$I_{DSM}$	31.5	A
		25.5	
Avalanche Current <sup>C</sup>	$I_{AS}$	30	A
Avalanche energy <sup>C</sup>	$E_{AS}$	135	mJ
$V_{DS}$ Spike <sup>I</sup>	$V_{SPIKE}$	48	V
Power Dissipation <sup>B</sup>	$P_D$	46	W
		18.5	
Power Dissipation <sup>A</sup>	$P_{DSM}$	4.1	W
		2.6	
Junction and Storage Temperature Range	$T_J, T_{STG}$	-55 to 150	°C

### Thermal Characteristics

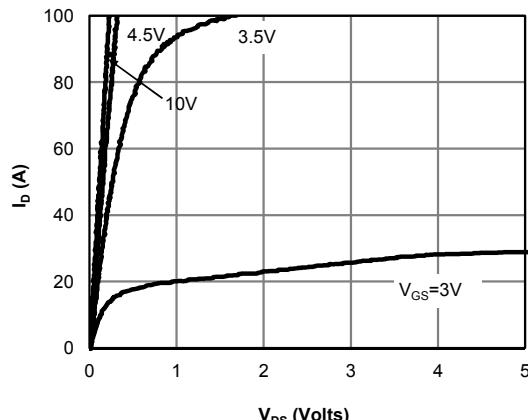
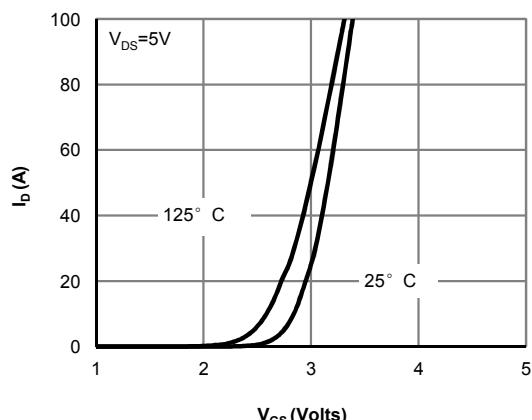
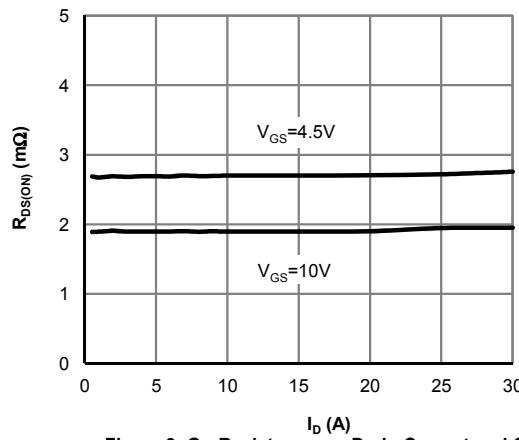
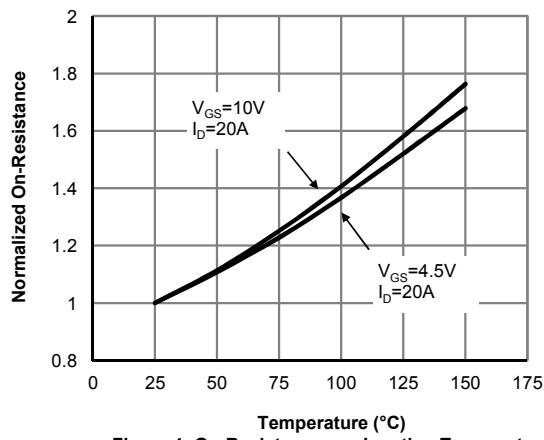
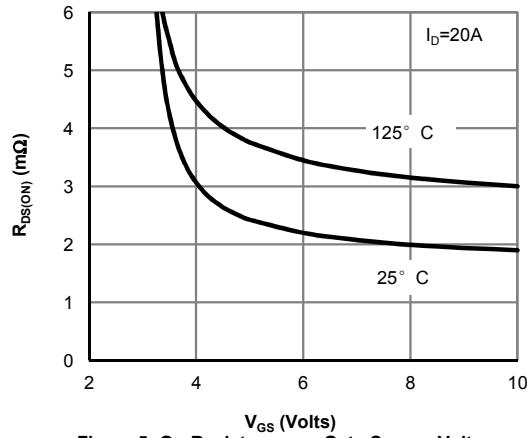
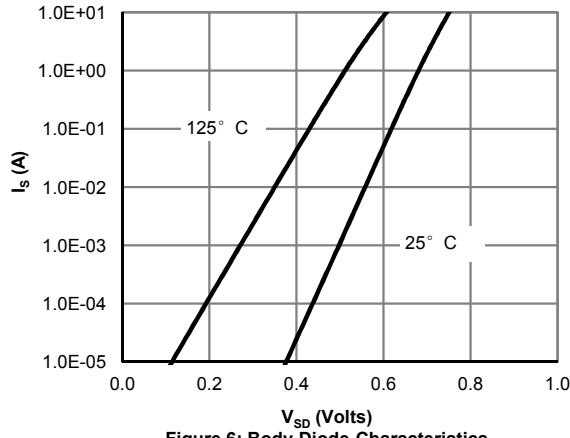
Parameter	Symbol	Typ	Max	Units
Maximum Junction-to-Ambient <sup>A</sup>	$R_{\theta JA}$	25	30	°C/W
		50	60	°C/W
Maximum Junction-to-Case	$R_{\theta JC}$	1.8	2.7	°C/W

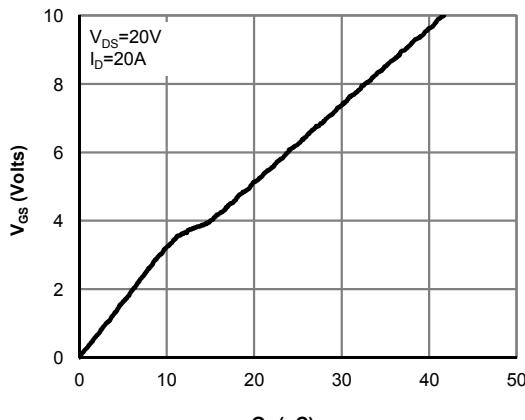
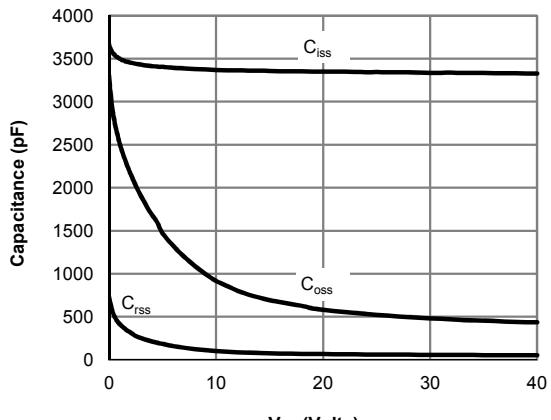
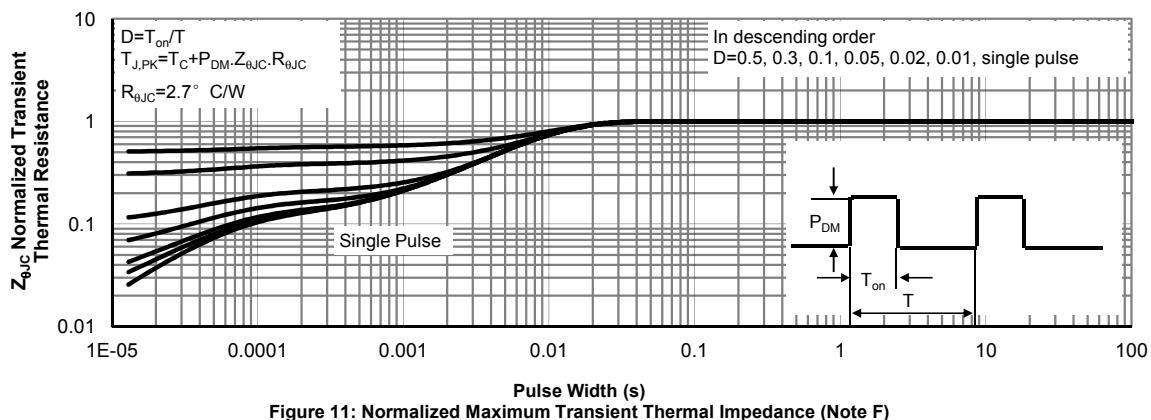
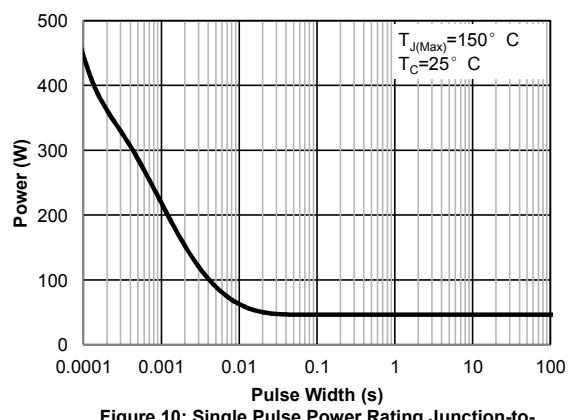
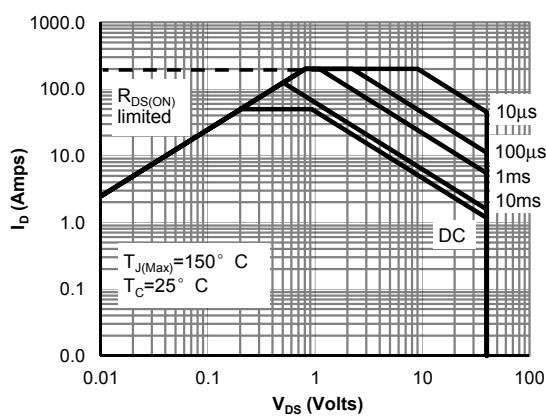
**Electrical Characteristics ( $T_J=25^\circ\text{C}$  unless otherwise noted)**

Symbol	Parameter	Conditions	Min	Typ	Max	Units
<b>STATIC PARAMETERS</b>						
$\text{BV}_{\text{DSS}}$	Drain-Source Breakdown Voltage	$I_D=250\mu\text{A}, V_{GS}=0\text{V}$	40			V
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{DS}=40\text{V}, V_{GS}=0\text{V}$ $T_J=55^\circ\text{C}$		1	5	$\mu\text{A}$
$I_{GSS}$	Gate-Body leakage current	$V_{DS}=0\text{V}, V_{GS}=\pm20\text{V}$			$\pm100$	nA
$V_{GS(\text{th})}$	Gate Threshold Voltage	$V_{DS}=V_{GS}, I_D=250\mu\text{A}$	1.4	1.85	2.4	V
$R_{DS(\text{ON})}$	Static Drain-Source On-Resistance	$V_{GS}=10\text{V}, I_D=20\text{A}$ $T_J=125^\circ\text{C}$		1.9	2.3	$\text{m}\Omega$
		$V_{GS}=4.5\text{V}, I_D=20\text{A}$		3.0	3.7	$\text{m}\Omega$
$g_{FS}$	Forward Transconductance	$V_{DS}=5\text{V}, I_D=20\text{A}$		100		S
$V_{SD}$	Diode Forward Voltage	$I_S=1\text{A}, V_{GS}=0\text{V}$		0.67	1	V
$I_S$	Maximum Body-Diode Continuous Current <sup>G</sup>				50	A
<b>DYNAMIC PARAMETERS</b>						
$C_{iss}$	Input Capacitance	$V_{GS}=0\text{V}, V_{DS}=20\text{V}, f=1\text{MHz}$		3350		pF
$C_{oss}$	Output Capacitance			580		pF
$C_{rss}$	Reverse Transfer Capacitance			65		pF
$R_g$	Gate resistance	$f=1\text{MHz}$	0.4	0.85	1.3	$\Omega$
<b>SWITCHING PARAMETERS</b>						
$Q_g(10\text{V})$	Total Gate Charge	$V_{GS}=10\text{V}, V_{DS}=20\text{V}, I_D=20\text{A}$		42	60	nC
$Q_g(4.5\text{V})$	Total Gate Charge			18	26	nC
$Q_{gs}$	Gate Source Charge			11.5		nC
$Q_{gd}$	Gate Drain Charge			3.5		nC
$t_{D(\text{on})}$	Turn-On DelayTime	$V_{GS}=10\text{V}, V_{DS}=20\text{V}, R_L=1.0\Omega, R_{\text{GEN}}=3\Omega$		9		ns
$t_r$	Turn-On Rise Time			3.5		ns
$t_{D(\text{off})}$	Turn-Off DelayTime			34		ns
$t_f$	Turn-Off Fall Time			3		ns
$t_{rr}$	Body Diode Reverse Recovery Time	$I_F=20\text{A}, di/dt=500\text{A}/\mu\text{s}$		16		ns
$Q_{rr}$	Body Diode Reverse Recovery Charge	$I_F=20\text{A}, di/dt=500\text{A}/\mu\text{s}$		42		nC

- A. The value of  $R_{\text{DS(on)}}$  is measured with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $T_A=25^\circ\text{C}$ . The Power dissipation  $P_{\text{DS(on)}}$  is based on  $R_{\text{DS(on)}} \leq 10\text{s}$  and the maximum allowed junction temperature of  $150^\circ\text{C}$ . The value in any given application depends on the user's specific board design.
- B. The power dissipation  $P_D$  is based on  $T_{J(\text{MAX})}=150^\circ\text{C}$ , using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.
- C. Single pulse width limited by junction temperature  $T_{J(\text{MAX})}=150^\circ\text{C}$ .
- D. The  $R_{\text{DS(on)}}$  is the sum of the thermal impedance from junction to case  $R_{\text{JJC}}$  and case to ambient.
- E. The static characteristics in Figures 1 to 6 are obtained using  $<300\mu\text{s}$  pulses, duty cycle 0.5% max.
- F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of  $T_{J(\text{MAX})}=150^\circ\text{C}$ . The SOA curve provides a single pulse rating.
- G. The maximum current rating is package limited.
- H. These tests are performed with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $T_A=25^\circ\text{C}$ .
- I. The spike duty cycle 5% max, limited by junction temperature  $T_{J(\text{MAX})}=125^\circ\text{C}$ .

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**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**

**Figure 1: On-Region Characteristics (Note E)**

**Figure 2: Transfer Characteristics (Note E)**

**Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)**

**Figure 4: On-Resistance vs. Junction Temperature (Note E)**

**Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)**

**Figure 6: Body-Diode Characteristics (Note E)**

**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**

**Figure 7: Gate-Charge Characteristics**

**Figure 8: Capacitance Characteristics**


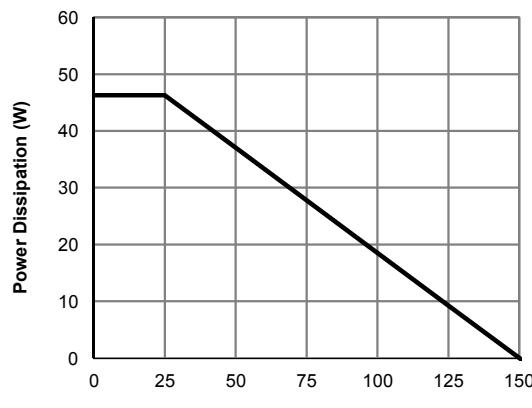
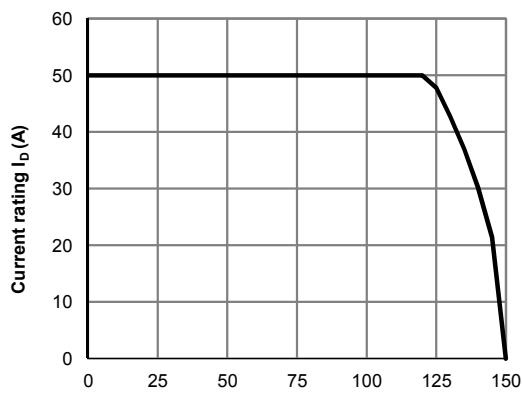
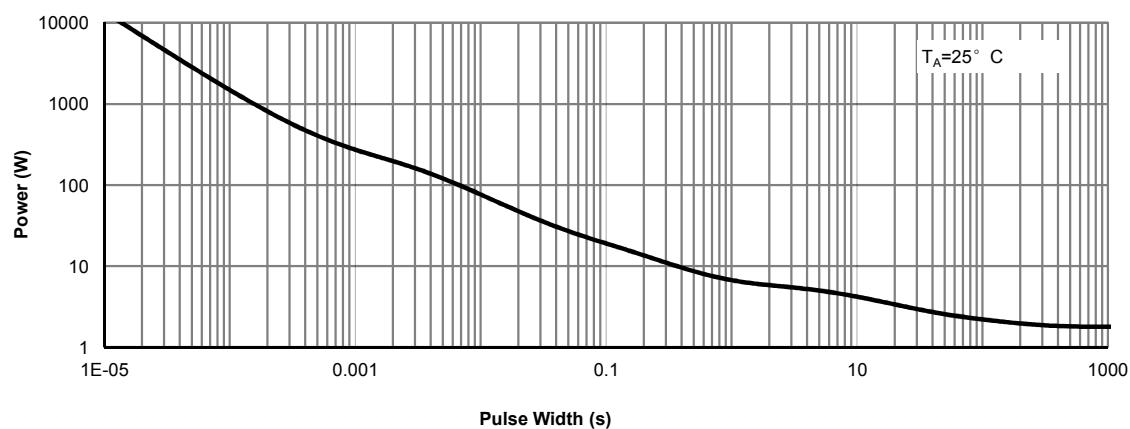
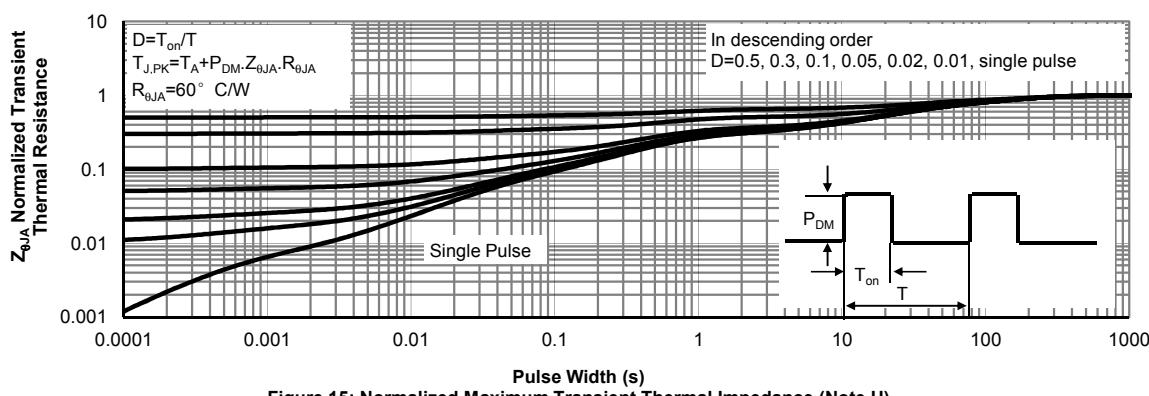
**TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS**

**Figure 12: Power De-rating (Note F)**

**Figure 13: Current De-rating (Note F)**

**Figure 14: Single Pulse Power Rating Junction-to-Ambient (Note H)**

**Figure 15: Normalized Maximum Transient Thermal Impedance (Note H)**

Figure A: Gate Charge Test Circuit &amp; Waveforms

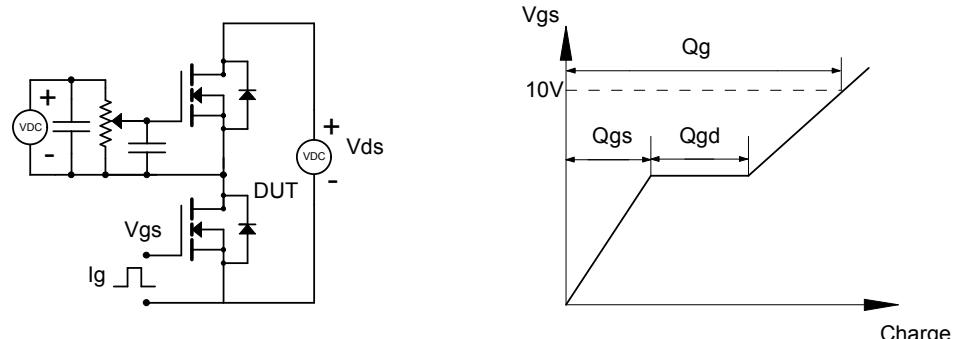


Figure B: Resistive Switching Test Circuit &amp; Waveforms

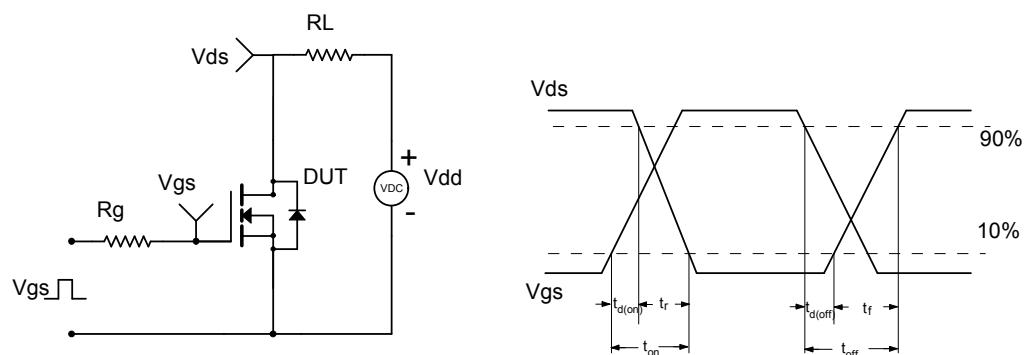


Figure C: Unclamped Inductive Switching (UIS) Test Circuit &amp; Waveforms

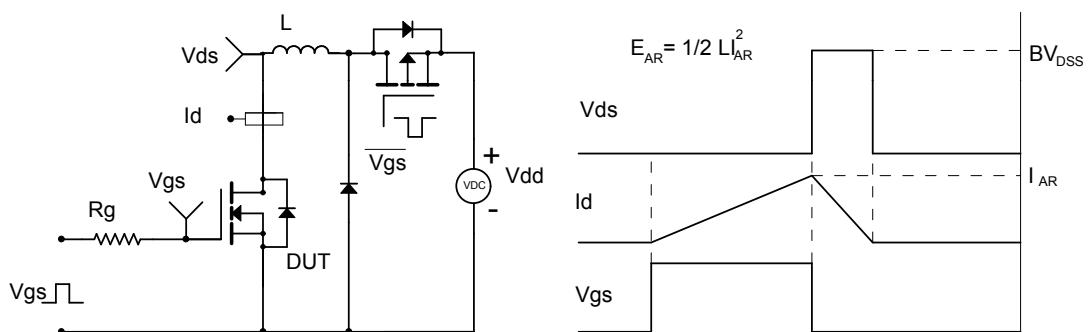


Figure D: Diode Recovery Test Circuit &amp; Waveforms

